

STP7NB30 STP7NB30FP

N - CHANNEL 300V - 0.75 Ω - 7A - TO-220/TO-220FP PowerMESHTM MOSFET

| TYPE | V _{DSS} | R _{DS(on)} | ΙD |
|------------|------------------|---------------------|-----|
| STP7NB30 | 300 V | < 0.90 Ω | 7 A |
| STP7NB30FP | 300 V | < 0.90 Ω | 4 A |

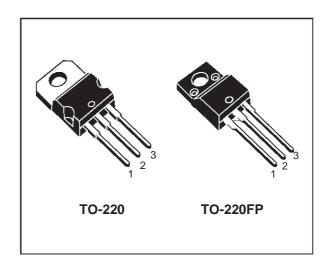
- TYPICAL R_{DS(on)} = 0.75Ω
- EXTREMELY HIGH dv/dt CAPABILITY
- 100% AVALANCHE TESTED
- VERY LOW INTRINSIC CAPACITANCES
- GATE CHARGE MINIMIZED

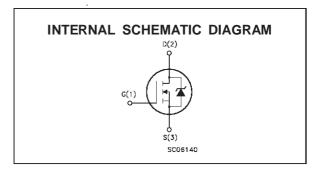
DESCRIPTION

Using the latest high voltage MESH OVERLAYTM process, STMicroelectronics has designed an advanced family of power MOSFETs with outstanding performances. The new patent pending strip layout coupled with the Company's proprietary edge termination structure, gives the lowest RDS(on) per area, exceptional avalanche and dv/dt capabilities and unrivalled gate charge and switching characteristics.

APPLICATIONS

- HIGH CURRENT, HIGH SPEED SWITCHING
- SWITCH MODE POWER SUPPLIES (SMPS)
- DC-AC CONVERTERS FOR WELDING EQUIPMENT AND UNINTERRUPTIBLE POWER SUPPLIES AND MOTOR DRIVE





ABSOLUTE MAXIMUM RATINGS

| Symbol | Parameter | Va | Unit | |
|---------------------|---|------------|------------|------|
| | | STP7NB30 | STP7NB30FP | 1 |
| V _{DS} | Drain-source Voltage (V _{GS} = 0) | 30 | 00 | V |
| V_{DGR} | Drain- gate Voltage ($R_{GS} = 20 \text{ k}\Omega$) | 30 | 00 | V |
| V_{GS} | Gate-source Voltage | ± | 30 | V |
| I _D | Drain Current (continuous) at T _c = 25 °C | 7 | 4 | Α |
| I _D | Drain Current (continuous) at T _c = 100 °C | 4.4 2.5 | | Α |
| I _{DM} (•) | Drain Current (pulsed) | 28 | 28 | Α |
| P _{tot} | Total Dissipation at T _c = 25 °C | 85 | 30 | W |
| | Derating Factor | 0.68 | 0.24 | W/°C |
| dv/dt(1) | Peak Diode Recovery voltage slope | 5.5 | 5.5 | V/ns |
| V _{ISO} | Insulation Withstand Voltage (DC) | | | V |
| T _{stg} | Storage Temperature | -65 to 150 | | °C |
| Tj | Max. Operating Junction Temperature | 15 | °C | |

(•) Pulse width limited by safe operating area

(1) $I_{SD} \le 7A$, $di/dt \le 200 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{(BR)DSS}$, $Tj \le T_{JMAX}$

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STP7NB30/STP7NB30FP

THERMAL DATA

| | | | TO-220 | TO-220FP | |
|-----------------------|---|-------|--------|----------|------|
| R _{thj-case} | Thermal Resistance Junction-case | Max | 1.47 | 4.17 | °C/W |
| R _{thj-amb} | Thermal Resistance Junction-ambient | Max | 62 | .5 | °C/W |
| R _{thc-sink} | Thermal Resistance Case-sink | Тур | 0. | 5 | °C/W |
| T ₁ | Maximum Lead Temperature For Soldering Pu | rpose | 30 | 00 | °C |

AVALANCHE CHARACTERISTICS

| Symbol | Parameter | Max Value | Unit |
|-----------------|---|-----------|------|
| I _{AR} | Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T _j max) | 7 | А |
| E _{AS} | Single Pulse Avalanche Energy (starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 50$ V) | 150 | mJ |

ELECTRICAL CHARACTERISTICS ($T_{case} = 25$ ^{o}C unless otherwise specified) OFF

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|----------------------|--|---|------|------|---------|----------|
| V _{(BR)DSS} | Drain-source Breakdown Voltage | $I_D = 250 \ \mu A$ $V_{GS} = 0$ | 300 | | | V |
| I _{DSS} | Zero Gate Voltage Drain Current (V _{GS} = 0) | $V_{DS} = Max Rating$ $V_{DS} = Max Rating$ $T_c = 125$ °C | | | 1 10 | μΑ μΑ |
| I _{GSS} | Gate-body Leakage Current (V _{DS} = 0) | $V_{GS} = \pm 30 \text{ V}$ | | | ± 100 | nA |

ON (*)

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|---------------------|--------------------------------------|--|------|------|------|------|
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS} = V_{GS}$ $I_D = 250 \mu A$ | 3 | 4 | 5 | V |
| R _{DS(on)} | Static Drain-source On Resistance | $V_{GS} = 10V I_D = 3.5 \text{ A}$ | | 0.75 | 0.9 | Ω |
| I _{D(on)} | On State Drain Current | $V_{DS} > I_{D(on)} \times R_{DS(on)max}$ $V_{GS} = 10 \text{ V}$ | 7 | | | А |

DYNAMIC

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|--|--|---|------|------------------|------|----------------|
| gfs (*) | Forward Transconductance | $V_{DS} > I_{D(on)} \times R_{DS(on)max}$ $I_D = 3.5 \text{ A}$ | 1.5 | | | S |
| C _{iss} C _{oss} C _{rss} | Input Capacitance Output Capacitance Reverse Transfer Capacitance | $V_{DS} = 25 \text{ V}$ f = 1 MHz $V_{GS} = 0$ | | 500 100 15 | | pF pF pF |

ELECTRICAL CHARACTERISTICS (continued)

SWITCHING ON

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|--|--|--|------|------------------|------|----------------|
| t _{d(on)} t _r | Turn-on Time Rise Time | $V_{DD} = 150 \text{ V}$ $I_D = 3.5 \text{ A}$ $R_G = 4.7 \Omega$ $V_{GS} = 10 \text{ V}$ (see test circuit, figure 3) | | 13 8 | | ns ns |
| Q _g Q _{gs} Q _{gd} | Total Gate Charge Gate-Source Charge Gate-Drain Charge | $V_{DD} = 240 \text{ V}$ $I_{D} = 7.0 \text{ A}$ $V_{GS} = 10 \text{ V}$ | | 17 7.5 6.5 | 25 | nC nC nC |

SWITCHING OFF

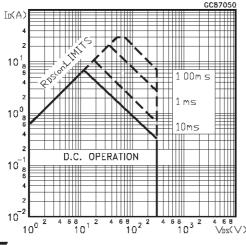
| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|----------------------|-----------------------|---|------|------|------|------|
| t _{r(Voff)} | Off-voltage Rise Time | $V_{DD} = 240 \text{ V} I_{D} = 7.0 \text{ A}$ | | 8 | | ns |
| t _f | Fall Time | $R_{G} = 4.7 \Omega V_{GS} = 10 V$ | | 15 | | ns |
| tc | Cross-over Time | (see test circuit, figure 5) | | 7 | | ns |

SOURCE DRAIN DIODE

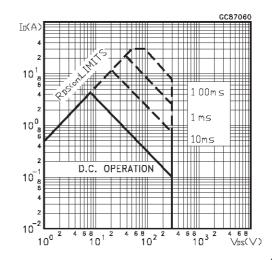
| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|---|--|--|------|------|-----------|--------|
| I _{SD} I _{SDM} (•) | Source-drain Current Source-drain Current (pulsed) | | | | 7.0 28 | A A |
| V _{SD} (*) | Forward On Voltage | $I_{SD} = 7.0 \text{ A} V_{GS} = 0$ | | | 1.6 | V |
| t _{rr} | Reverse Recovery Time | $I_{SD} = 7.0 \text{ A}$ di/dt = 100 A/ μ s $V_{DD} = 100 \text{ V}$ $T_i = 150 \text{ °C}$ | | 190 | | ns |
| Q _{rr} | Reverse Recovery Charge | (see test circuit, figure 5) | | 1.1 | | μC |
| I _{RRM} | Reverse Recovery Current | | | 11.5 | | А |

^(*) Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %

Safe Operating Area for TO-220



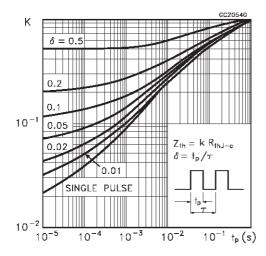
Safe Operating Area for TO-220FP



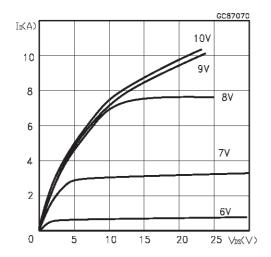
4

^(•) Pulse width limited by safe operating area

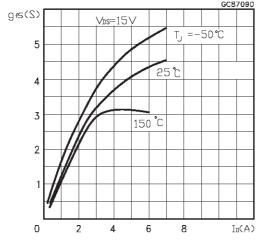
Thermal Impedance for TO-220



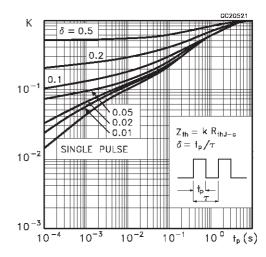
Output Characteristics



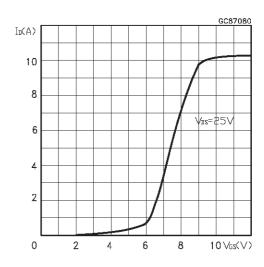
Transconductance



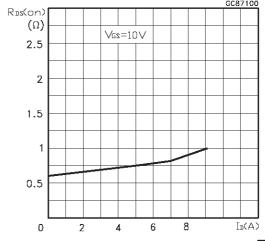
Thermal Impedance for TO-220FP



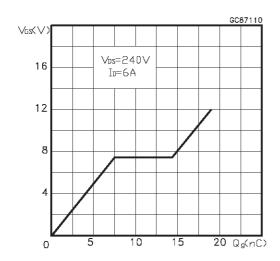
Transfer Characteristics



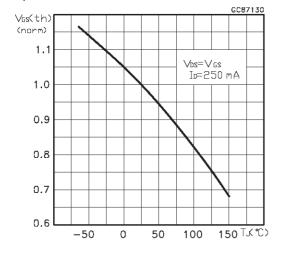
Static Drain-source On Resistance



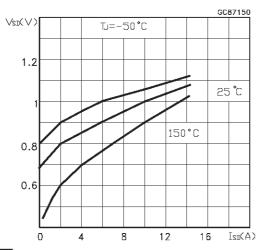
Gate Charge vs Gate-source Voltage



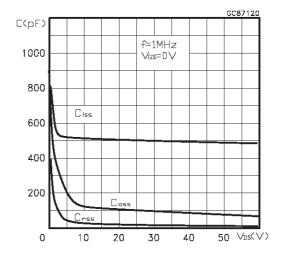
Normalized Gate Threshold Voltage vs Temperature



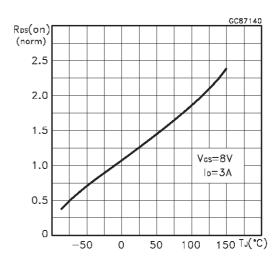
Source-drain Diode Forward Characteristics



Capacitance Variations



Normalized On Resistance vs Temperature



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Fig. 1: Unclamped Inductive Load Test Circuit

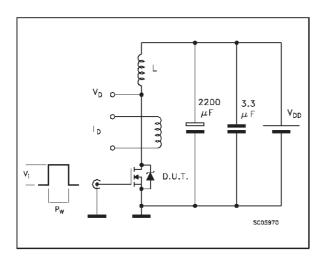


Fig. 3: Switching Times Test Circuits For Resistive Load

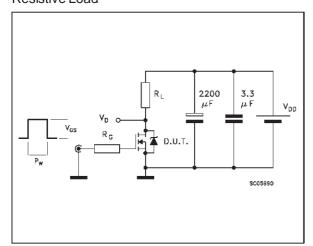


Fig. 5: Test Circuit For Inductive Load Switching And Diode Recovery Times

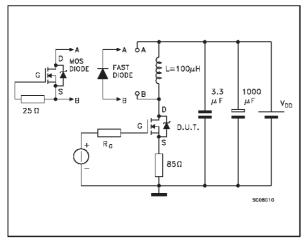


Fig. 2: Unclamped Inductive Waveform

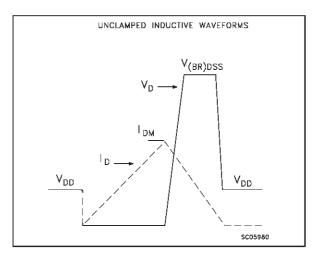
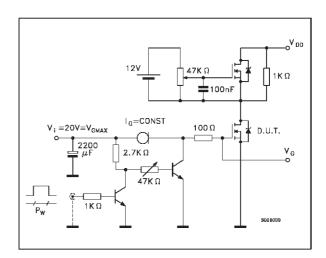
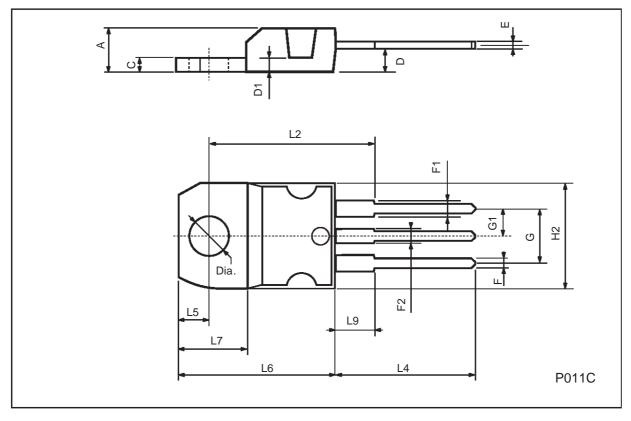


Fig. 4: Gate Charge test Circuit



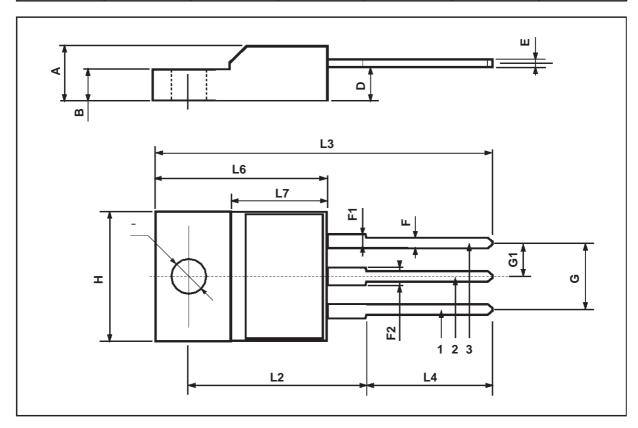
TO-220 MECHANICAL DATA

| DIM. | | mm | | | inch | |
|--------|-------|------|-------|-------|-------|-------|
| Dilvi. | MIN. | TYP. | MAX. | MIN. | TYP. | MAX. |
| А | 4.40 | | 4.60 | 0.173 | | 0.181 |
| С | 1.23 | | 1.32 | 0.048 | | 0.051 |
| D | 2.40 | | 2.72 | 0.094 | | 0.107 |
| D1 | | 1.27 | | | 0.050 | |
| E | 0.49 | | 0.70 | 0.019 | | 0.027 |
| F | 0.61 | | 0.88 | 0.024 | | 0.034 |
| F1 | 1.14 | | 1.70 | 0.044 | | 0.067 |
| F2 | 1.14 | | 1.70 | 0.044 | | 0.067 |
| G | 4.95 | | 5.15 | 0.194 | | 0.203 |
| G1 | 2.4 | | 2.7 | 0.094 | | 0.106 |
| H2 | 10.0 | | 10.40 | 0.393 | | 0.409 |
| L2 | | 16.4 | | | 0.645 | |
| L4 | 13.0 | | 14.0 | 0.511 | | 0.551 |
| L5 | 2.65 | | 2.95 | 0.104 | | 0.116 |
| L6 | 15.25 | | 15.75 | 0.600 | | 0.620 |
| L7 | 6.2 | | 6.6 | 0.244 | | 0.260 |
| L9 | 3.5 | | 3.93 | 0.137 | | 0.154 |
| DIA. | 3.75 | | 3.85 | 0.147 | | 0.151 |



TO-220FP MECHANICAL DATA

| DIM. | | mm | | | inch | |
|--------|------|------|------|-------|-------|-------|
| Dilvi. | MIN. | TYP. | MAX. | MIN. | TYP. | MAX. |
| А | 4.4 | | 4.6 | 0.173 | | 0.181 |
| В | 2.5 | | 2.7 | 0.098 | | 0.106 |
| D | 2.5 | | 2.75 | 0.098 | | 0.108 |
| E | 0.45 | | 0.7 | 0.017 | | 0.027 |
| F | 0.75 | | 1 | 0.030 | | 0.039 |
| F1 | 1.15 | | 1.7 | 0.045 | | 0.067 |
| F2 | 1.15 | | 1.7 | 0.045 | | 0.067 |
| G | 4.95 | | 5.2 | 0.195 | | 0.204 |
| G1 | 2.4 | | 2.7 | 0.094 | | 0.106 |
| Н | 10 | | 10.4 | 0.393 | | 0.409 |
| L2 | | 16 | | | 0.630 | |
| L3 | 28.6 | | 30.6 | 1.126 | | 1.204 |
| L4 | 9.8 | | 10.6 | 0.385 | | 0.417 |
| L6 | 15.9 | | 16.4 | 0.626 | | 0.645 |
| L7 | 9 | | 9.3 | 0.354 | | 0.366 |
| Ø | 3 | | 3.2 | 0.118 | | 0.126 |



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